

SANKO Coating Thickness Meter SWT-7000IV Instruction Manual



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Attention for safety (to use safely and correctly)

To prevent you and your properties from damaging please take some time to read thoroughly this "Attention for Safety" and use this main unit correctly. And keep these instructions attentive to read when necessary.



Attention for safety (to use safely and correctly)

🕂 Warning



Attention for safety (to use safely and correctly)

Attention



Do not use Benzene or Thinner for cleaning and spray pesticides on the meter, otherwise it may cause cracks or malfunctions.



Do not store the meter in places getting high in temperatures such as in a car in strong sunlight or near heaters, otherwise it will be hazardous to the meter and may cause malfunctions.



Do not step, trample down nor put anything on the meter, otherwise it may cause malfunctions or injuries.



Keep the meter away off rubber-made articles or vinyl articles. A lengthy contact between the meter and them may cause stickiness and it may be difficult to get rid of them.

Notes

- Please read this manual thoroughly for correct operations before getting started.
- This meter is a precision gauge. Please handle with care.
- Do not tug, bend, fold or curl up forcefully the cables of probes.
- Do not knock or scratch objects with the tip of a probe.
- Keep the tip of a probe clean. A slight amount of dust may cause errors in measurements.
- Clean the meter and store it in free from dust and moisture after operation.
- To keep precision with a gauge please contact us for a periodical inspection.
- Keep the meter away off electric noises, shocks or magnetic fields when in a use, otherwise it may cause malfunctions.

Get started

- Contents in a package Please make sure if the following items sre included.
 - Main unit
 SWT-7000IV
 - Dry batteries LR6 (2 pieces)
 - SWT / SAMAC series CD
 - SWT-7000IV Instruction Manual (this manual)
 - USB driver
 - ◆ Instllation of USB transfer driver
 - Inspection certificate (warranty)-cum-user registration sheet (This warranty is valid only in Japan)
 - Hand strap cord (attach directly to main unit)
 - · Carrying case for main unit

Names of part



Probe connector

Connect an optional-exclusive SWT probe to the probe connector.

- (1) To measure a film thickness of coated, plated, lining layer on substrates made of ferrous material please use a probe of [SFe] series for the connection.
- (2) To measure a film thickness of coated, lining layer on substrates made of non-ferrous materials such as Aluminum, etc. please use a probe of [SNFe] series for the connection.
- (3) To measure a film thickness on a coated metal substrate made of either ferrous or non-ferrous please use a Dual type probe [SFN-325].

Display

It indicates measurement results, operation guides, or malfunction status. With a backlight.

Keys

(1) [①] (Power source) key

It switches ON or OFF.

(2) [ZERO] key

To set a ZERO point of substrate before measuring.

(3) 「▲☆」key, 「▼」key

They are a Backlight key / an adjusting key to set a neumericall value for standard adjustments.

(4) 「CAL」 key

This is to start up and finish the Calibration standard, and delete an abnormal value taken during adjustment process.

(activates only when 「Zeroing」,「Calibration standard」 is processed with combination with 「▼」 key)

% Power source key /operation keys activate setting of various kinds of functions in combination with other keys.

Hand strap

Hang the meter through a strap over your wrist never to drop it.

• AC adaptor connctor

A conector to connect the AC adaptor (option).

• USB cable connctor

A conector to connect the USB cable (option) for data transfer.

Battery compartment

It contains 2 pieces of dry battery (LR6).

Tilt stand

Set up the tilt stand to use this meter in a raised position.



Caution
The tilt stand does not come off. Do not remove it forcibly.
The tilt stand cannot be used when AC adaptor or USB cable are connected.

Items displayed on LCD



- (1) Indicates [ZERO cal.] (Zeroing) or [Cal. w. foil] (Calibration Standard), [2-foil's cal] when in process. It never appears on the reading except when in process of these adjustments.
- (2) At Auto Selection mode, one of the three (AUTO), (Fe), and (NFe) is displayed.
 - At Corresponding mode to substrate, **Fe** is displayed when being setting for exclusively Ferrous substrate, **NFe** for exclusively Non-ferrous substrate.
- ③ Measured data is displayed.
- ④ BAT mark is displayed with 2 steps when battery has runn out for replacement.
- 5 Setted unit is displayed.

" μ m" display automatically switches to "mm" display when it exceeds 999 μ m.

(6) Backlight: The light goes on when Backlight is set to ON.

How to fit batteries

- 1) Raise the tilt stand.
- 2 Open the battery lid on the rear of the main unit.
 - Press $\lceil \nabla \rfloor$ mark on the top of the lid and slide it down.
- ③ Insert batteries.
 - Ensure correct battery polarity \oplus , Θ for placement.
- (4) Close the battery lid and put the tilt stand back.
- % When changing batteries and inadvently switch ing ON, but that is not defective at all.

Caution

- Use specified and new (check battery-life) batrries or ones supplied in this package.
- An incorrect use of batteries may cause leakages, bursts. Do not intermingle new ones with different tyepss of batteries.
- Take out batteries to store when not in use for a long absence, or that may cause Leakages to breakdown.
- Keep batteries away off pets and children.
- Comply to the regulations and laws in your Local Authorities when disposing of batteries.

O About reading display

When placing batteries in the main unit, the messages and warning below on the screen may be displayed. And these are not breakdowns, wait until the reading disappears with a beeping sound. When connecting or disconnecting probe please switch Power source to OFF.





Batteries have run out when the display on the main unit indicates the mark BAT listed below. Replace with new batteries.



Also, displayed (Fe) when SFe-probe is connected, and (NFe) when SNFe-probe is connected.

How to connect, disconnect probes

- Connect an optional, exclusive SWT probe to the main unit Select one of the probes suited for your application.
 - ◇ If the substrates made of ferrous material, please use a probe of 「SFe」 series or a Dual type probe 「SFN-325」.
 - ◇ If the substrates made of non-ferrous materials such as Aluminum, please use a probe of 「SNFe」 series or a Dual type probe 「SFN-325」.

Insert a probe plug into the probe connector of the main unit.

Make sure of aligning the keyway, push the connector into place until the claps are locked. % If the direction is reversed, it will not enter.



- Remove the exclusive probe from the main unit.
 Pull off the probe carefully by bending inward clasps at the both ends of the probe body to release the clasps.
 - \ref{M} Do not pull off by force or it may cause damages.

Caution

Make sure that Power switches to off when connecting or disconnecting the exclusive SWT probes.

Or else, it may cause damages to connect or disconnect while Power is on.

How to hold probes



Tip to press against a measurement object

Quickly and calmly press perpendiculary against the object by grabing the probe as illustrated. It beeps and the reading screen shows the measuring result.

When it does not beep, lift it $5\sim7$ cm above the object and try again to take measurements.

How to press a probe to an object

- Keep the probe 5 cm or over away off metallic objects when not in use of measuring.
- Press the tip of the probe perpendicularly against a measurement object.
 X Tilting may cause large errors.
- Press the probe quickly and smoothly to objects.
 X A slow-acting press may cause large errors.



Caution

- Do not smash or hit the probe against objects, or it may cause damages to probes and to objects.
- Do not scrape, scrub objects with the probe except in a special measurement.
 - Or it may break the tip of the probe and cause damages to the tip and surface of objects.

How to operate

(1) How to switch power source



The buzzer beeps and this main unit is switched to OFF.

(3) Zeroing

After switching ON, it is capable of getting started on measurements and adjutments when the reading [START UP PHASE...] disapeared.

- ※ Generally, the meter makes errors depending on material formation and shapes to be measured. To minimize measurement errors and obtain as accurate results as possible please be sure of carrying out 2 kinds of adjustments of [Zeroing] and [Calibration standard] before measuring process.
- ※ Prepare the identical material and shape to a measuring object. (This is designated as a 「Zero plate」.)



The buzzer beeps.



The reading 【ZERO cal.】 in the upper left disappears. Zeroing completed and the main unit becomes possible to take measuring and adjusting operations.

Press the probe to the [Zero plate] several times and make sure the measuring result indicates in the neighborhood of "0".

When the measured value results in largely off "0", please try again zeroing from the beginning. There is a case when calibration is not correctly made.

• "LLLL" displayed on the screen during a time of zeroing means that the calibration point heavily deviates from the standard.

Please make sure that the metal substrate is not processed with other materials such as plating and repeat the zeroing until a stable in the neighborhood of "0" is obtained.

X After performing Zeroing, the previous [Zeroing value] is deleted, and the last entry of [Zeroing value] is stored.

(4) Calibration standard (CAL)

- Prepare the [Zero Plate] used for [Zeroing].
- Prepare the [Thickness standard] that are the same thick as the measuring film or thicker than that.
- Place the 「Thickness standard」 on the 「Zero Plate」.
- Press CAL key.



Press the probe to the Thikness standard on the Zero plate. It beeps whenever pressing.



After adjusting the reading value to the Thickness standard, press $\fboxtimescale CAL$ key.

The buzzer beeps, [cal. w. foil] on the upper left disappears and it returns to a measuring mode.



- It is correct that numerical values measured by pressing the probe a few times to the [Thickness standard] on the [Zero plate] indicates the thickness in the neighborhood of the [Thickness standard].
- When the measured value results in largely off the Thickness standard please try again [Calibration standard] from the beginning.
- X After performing Calibration standard , the previous [Calibration standard value] is deleted, and the last entry of [Calibration standard value] is stored.

(5) Zeroing - in special cases -

In case of being painted as shown with multi-layers on the substrate there may be needs to measure thicknesses of each layer. For example, measuring only the thickness of the 4th layer please zero as an assumed 「Zero point」 at the surface of the 3rd layer stacked on the substrate and take 「Zeroing」, 「Calibration standard」 as the aforementioned (3), (4).



Releasing of special-case zeroing

When zeroing again on the substrate after having finished the above measurements and if the combined thickness of 3 coating layers from 1^{st} to 3^{rd} exceeds 50 μ m, please zero the meter on the following procedures. If the thickness of 3 combined layers is bellow 50 μ m, take the same procedure as usual zeroing to release.

 Prepare the identical material and shape to a measuring object. (This is designated as a 「Zero plate」.)

Press ZERO key. The buzzer beeps.

CAL key changes to one data "deletion" function.

【ZERO Cal.】		
1. Measure subst −rate several times.		
2. press ZERO key.		

Press the probe to the Zero plate. The buzzer beeps, beeps, beeps 3 times.



The buzzer beeps.



The reading 【ZERO cal.】 in the upper left disappears. Zeroing completed and the main unit becomes possible to take measuring and adjusting operations.

● Press the probe to the 「Zero plate」 several times and make sure the measuring result indicates in the neighborhood of "0".

When the measured value results in largely off "0", please try again zeroing from the beginning. There is a case when calibration is not correctly made.

• "LLLL" displayed on the screen during a time of zeroing means that the calibration point heavily deviates from the standard.

Please make sure that the metal substrate is not processed with other materials such as plating and repeat the zeroing until a stable in the neighborhood of "0" is obtained.

X After performing Zeroing, the previous [Zeroing value] is deleted, and the last entry of [Zeroing value] is stored.

(6) 2-point calibration in case it is difficult to perform [Zeroing]

When it is difficult to adjust[[]Zeroing_]in a usual method on a rough surface such as the Blast steel plate, it is effective also to adjust by using <code>[]two pieces of different thickness of the Thicknesses standard]</code>.

Caution

It is not possible to use both this calibration method and other calibration ones together, or mixing them together.

Should were the methods taken, measuring results could be the wrong values.

 Prepare the same blast-steel-plate in material as the objective base and two pieces of different thicknesses of the Thickness standards.

Please choose the suitable difference of thickness standards from the list below.

Predicting film thickness	Difference of thickness standard
~ 49.9 μm	10 μ m or over
50.0∼99.9 µm	25 μ m or over
100.0∼499.9 µm	50 μ m or over
500 ~ 999 μm	199 μ m or over
1.0 ~ 2.5 mm	0.5 mm or over

Press and hold the ZERO key for 3 seconds.

The buzzer beeps.



CAL key changes to one data "deletion" function.

Stack the thinner 「Thickness standard」 on the substrate and press the probe on it.

The buzzer beeps whenever pressing the probe.

[2-f. c.] < (Fe) < 27 < μm

2-foil calibration in process.

The measuring object is set for ferrous metal substrate.

Measured a mean value

When the measuring value results in largely off the "Thickness standard", press CAL + \checkmark key to delete the latest data out of measured values. It indicates "—" to delete all data.

After pressing certain times or 20 times, press $\boxed{\text{ZERO}}$ key.

The buzzer beeps, beeps 2 times.



- Repeat a measuring processes, 1~20 times by pressing the probe to the thinner [Thickness standard].
 (A mean value is displayed whenever a probe is pressed)
- When a measuring process reaches the 20th time, the buzzer beeps, beeps 2 times and afterward new entry is no more accepted.

A press of \checkmark or \checkmark key makes the buzzer beep and a mean value to the last measurement appears on the reading.







After adjusting the reading value to the Thickness standard, press ZERO key. The buzzer beeps.

$$\overline{\bigcirc}$$

【2-foil' s cal】 Measure thicker foil on metal several times.		
Afterward, press ZERO key.		

The buzzer beeps whenever pressing the probe.



After pressing certain times or 20 times, press ZERO key. The buzzer beeps, beeps 2 times.



μ m
 Repeat a measuring processes, 1~20 times by pressing the probe to the thicker [Thickness standard].
 (A mean value is displayed whenever a probe is pressed)

When a measuring process reaches the 20th time, the buzzer beeps, beeps 2 times and afterward new entry is no more accepted.

Measured a mean value

It indicates "--" to delete all data.





Stack the thicker 「Thickness standard」 on the substrate and press the probe on it.

When the measuring value results in largely off the

"Thickness standard", press CAL + **V** key

to delete the latest data out of measured values.



- It is correct that numerical values measured by pressing the probe a few times to the 「Thickness standard」 on the 「Zero plate」 indicates the thickness in the neighborhood of the 「Thickness standard」. Take the procedure with each 2 sheets of the Thickness standard」.
- When the measured value results in largely off the Thickness standard please try again [2-foils calibration] from the beginning.
- X After performing 2-foils calibration, the previous [Calibration value] is deleted, and the lastentry of [2-foils calibration value] is stored.

(7) How to delete calibration

Take the following procedures to delete calibration when the reading on the screen is locked or after batteries replaced or when it becomes impossible to process [Zeroing], [Calibration Standard](CAL).

X This operation procedures are taken when SWT is faulty. Usually, take adjustments with the old adjusted data stored. Automatically the old data is deleted and the new data is stored.



X Switch Power to OFF when intrruptting the deletion of calibaration.

The last measured substrate and value are displayed.

It becomes possible to take measurements and adjustment procedures of this main unit.

After deleting, take [Zeroing], [Calibration standard] procedures proceeding to measuring.

Measuring



Hang the meter through a strap over your wrist never to drop it.

When pressing the probe against the object with Power ON, the buzzer beeps.



Each time a probe is pressed to an object the buzzer beeps and the measuring result is displayed.

Measuring of Auto-selection by [SFN-325]

- (2) Non-ferrrous substarate measuring of film thickness at NFe mode.
- (3) Ferrous on Non-ferrous layered substarate measuring at Fe mode regadress of Fe thickness.



(4) Non-ferrous on ferrous layered substrate

- (4–1) Layered thickness Non–Ferrous and Film, 3.0 mm or less^{**} ••••• measure thickness of layered Non–Ferrous and Film in Fe mode.
- (4–2) Layered thickness Non–Ferrous and Film, 3.5 mm or over²⁶ · · · · · measure Film thickness in NFe mode.



Note:

- "HHHH" is displayed in a between area of 2 different layers and when special metals unidentified by Auto-selection.
- In case of adjusting by [Calibration standard] on Fe-substrate, [Calibration standard]foils made of Non-Ferrous metals such as BeCu can be used.
- In case substrates are not identified by Auto-selection mode, change to exclusive mode by [corresponding mode to a metal substrate].
 - In case of an example of (4-1), thickness of Film only can be measured at [Non-Ferrous] exclusive mode.
- X They may vary in compositions, characteristics, thicknesses of materials.

Function setting

(1) Setting of Non-Interrupt Measurement mode

As illustrated on the right figure, this mode is used when taking non-interrupt measurements for painting surfaces etc. Film thickness values are taken/displayed while press/holding probe on the object.



Substrate

A measuring value is held (displayed) when pressing a probe at standard mode, but in Non–Interrupt Measurement mode measuring values are taken/displayed about every 0.5 seconds interval while pressing a probe.

The buzzer beeps, beeps 2 times.

ZERO key and press

Hold



This main unit has turned into 「Non–Interrupt Measurement mode」. Data can be successively measured about 0.5 second intervals and the data is displayed with a beeping sound.

key.



Reaching to a measurable distance, the probe indicates the distance/thickness at the spot.

Display of measured values (displayed successively each 0.5 second interval).

X The Non-Interrupt function is stored when switching Power to OFF.

To return to the beginning, take the procedure of "Returning to the beginning" listed on the following page.



The moving measuring method at "Non–Interrupt Measuring Mode" may damage the measuring surface or the probe tip because of frictions made by sliding the probe on the surface. Please try fewer to take this method to minimize the frictions.

«Returning to the beginning»

To return [Non-Interrupt Measurement mode] to the beginning take the same procedures as at the initial setting.



The buzzer beeps, beeps 2 times.



[Non-Interrupt Measurement mode] has been released and returned to the beginning.



Measured values are stored until a next measurement is taken.

(2) Setting of resolutions

• Switch Power to OFF when Power is ON.

The reading values up to $500 \,\mu$ m can be switched in resolutions as below. It is possible to read resolution measurement results by the 0.1 μ m unit in the thickness of $(0 \sim 400 \,\mu$ m), and by the 0.5 μ m unit in the thickness of $(400 \sim 500 \,\mu$ m).

Hold CAL key and press () key for 3 seconds or over. The buzzer beeps, beeps 2 times. (Fe) 125. 2 μ m Displayed : $0 \sim 400 \,\mu$ m by the 0.1 μ m unit, $400 \sim 500 \,\mu$ m by the 0.5 μ m unit.

X This function is not released even if the Power source is switched to OFF.
When returning, take the operation procedures of "Returning to the beginning" as below.

«Returning to the beginning»

To return $[0.1 \,\mu$ m, $0.5 \,\mu$ mJ displayed resolutions to the beginning, take the same procedures as the above.



(3) Setting of units

This main unit is equipped with a function converting the unit to $\mbox{\sc fmil}\mbox{\sc J}$

- Switch Power to OFF when Power is ON.
- Press and hold 🔘 key for 10 seconds or over until the buzzer beeps, beeps 2 times.



This function is not released even if the Power source is switched to OFF.
 When returning, take the operation procedures of "Returning to the beginning" as below.

«Returning to the beginning»

To return [mil] unit to the beginning, take the same procedures as the above.

- Switch Power to OFF when Power is ON.
- Press and hold () key for 10 seconds or over until the buzzer beeps, beeps 2 times.



(4) Setting of Auto-Power-OFF function

When no entry of key operations and measuring procedures for 3 minutes, the main unit switcehes automatically to OFF to save battery. This function can be released by yhe following operations.

No entry for 3 minutes lasts, and then the buzzer beeps.



The message is displayed for about 5 seconds.

The buzzer beeps, and the main unit is switched to OFF.

《To Disable Auto-Power-OFF function》

• Switch Power to OFF when Power is ON.



X This function is not released even if the Power source is switched to OFF. To enable it, take the operation procedures of "To Enable Auto-Power-OFF function".



When no entry of key operations and measuring procedures lasts about for 3 minutes, the buzzer beeps and the power is switched to OFF.

X This function is not released even if the Power source is switched to OFF. To disable it, take the operation procedures of "To Disable Auto-Power-OFF function".

(5) Setting of corresponding mode to substrate with SFN-325 probe

When the SFN-325 probe is connected, the main unit automatically select a substrate for measuring objects, but in addition to the Auto-selection mode [Fe substrate exclusive mode], [NFe substrate exclusive mode] are ready to use.

In case it is not possible to identify the substrate by Auto-selection mode, change the mode on the following steps to take measurements with procedure as shown below.

※ When on Ex-factory, the unit is set to 「AUTO mode」.

- X This function is effective only when [SFN-325] probe is connected.
- % This function is kept live even if the Power is switched to OFF.

[EX-factory setting]



(6) Setting of Backlight

The LCD of this unit has a backlight function.

The bcklight can be used at the place which is dark and difficult to read messages on display.

《Lighting the Backlight》

Press and hold \checkmark key for 3 seconds or over.

The buzzer beeps, beeps 2 times and the backlight goes on.



Press and hold \checkmark key for 3 seconds or over.

It is shown when the backlight is ON.

«Lighting out the Backlight»



The mark and the backlight go off.

X This function is kept even if Power source switched to OFF.

Transferring data — Real time transfer -

Transfer data to a PC (personal computer) by using a USB cable. Download the USB transfer driver from our website.

- X Data is not transferred when the main unit is set to [Non-Intrerrupt Measuring mode]. Make sure beforehand that this main unit is set to [is set to Normal (hold) Measuring mode].
- X Even when the unit of this instrument is set to the $\lceil mil \rfloor$, the data transferred to the Transfer software is displayed with the $\lceil \mu m \rfloor$ unit.

Outright transferring measured data

- Prepare for a PC side.
- Connect a USB cable (option) to a PC.



This is a USB cable connector.

Hook up a UBS cable (option) to USB cable connector and the other sode to PC.

(Fe)
125
μ m

Data is sent out with a beeping sound whenever a measurement is taken.

Note to improve measuring accuracy

$\textcircled{1} \quad \mathsf{Zero \ plate}$

Prepare the same material, thick and shape plate as the measuring object for Zeroing and Calibration standard (CAL). Different materials may not bring about correct measuring results.

X As accessories to probe (option), "Zero plates" are **for testing purpose only**. Select a most optimal zero plate to meet actually measuring objects. (Please refer to page 12)

2 Thickness standard (foils)

Take Calibration standard (CAL) using a Thickness standard which is thicker or as thick as the measuring films.

% Use of a Thickness standard with a deviant thickness may cause errors. Replace worn-out or bent plates with new ones. In case non-accessorized plates are necessary (over 16μ m), contact a local sales office.

③ Quality of films to be measured

Magnetic metal contained in the films can correctly not be measured. In case of measuring elastic films, place aThickness standard of $30 \sim 50 \,\mu$ m thick on the object and subtract the thickness from the measuring value to avoid errors to becaused by elastic dents.

(4) Measurements of edges or angles

Magnetic fields in the neighborhood of the edges/the angles of a measuring object become uneven. $15\sim20$ mm closer part to the center of the object shall generally be measured. Pay attention to protruded part, curved part or unexpectedly deformed part.

(5) Measurements of rough faces

Roughness of a substrate, a measuring face affects measuring results. Take a mean value by measuring several places at a time.

6 Measurements of stretched part on faces

In some case stretched, rolled part occurred on a substrate, which may cause measuring errors. Take a mean value by measuring several places at a time.

7 Temperature

Operating temperature range is $0 \sim 40^{\circ}$ C.

Especially, large temperature differences between a main unit and a probe causes measuring error.

8 Residual magnetism, stray magnetic fields

Pay attention to transportation method of electromagnets, residual magnetism on substrates or arc welding, those of which emit strong magnetic fields to cause measuring errors.

Trouble shooting

Before contacting us please check with the following points.

Symptoms	Points to check	Measures to be taken
No response upon press of Γ	Are batteries worn out?	Replace them with new ones (2 ea.).
No response after replacing batteries and pressing a Γ ① J key.	Something wrong inside a main unit.	Contact us for repair.
BAT	Batteries is shorting.	They can be used for a while. Prepare for new batteries.
BAT	Batteries have worn out.	Replace them with new ones.
BATTERY is dead! Replace all of them with NEW BATTERY. 《Power OFF》	Out of batteries.	Replace them with new ones.
ERROR ! Hold the probe in the air. (Power OFF)	Possibly pressing probe to object too soon after pressing Г ① 」key.	Hold probe in air, keeping it away off measuring objects, metals during a time of "START UP ····" on screen.
ERROR ! Connect a probe before switched on. 《Power OFF》	Press 「 ① 」 key without connecting probe.	Press 「 ① 」 key after being sure of connecting probe.

Symptoms	Points to check	Measures to be taken
TROUBLE ! The probe may have trouble. Change it to the other one. 《Power OFF》	Something wrong with probe.	Contact us for repair.
TROUBLE ! The probe and the main unit may have trouble. Repairing needed. 《Power OFF》	Something wrong with probe/ main unit.	Contact us for repair.
Unable to transfer data.	 Is USB cable connected correctly ? Is PC side ready to operate ? 	 Connect USB cable correctly. (1) Install driver by our home page correctly. (2) Set Comport No.correctly.
Sudden interruption of data transfer.	 ① Does PC operate normally? ② PC side is not faulty. → Something wrong with main unit. 	 Check if something wrong with PC side. Contact us for repair.

Disclaimer

We are not liable for any damage to customers caused by the use or inability to use of this product (including built-in software and data).

Specifications

Main unit

Items	Applications		
Model name	Dual (Electromagnetic/Eddy current) type coating thickness meter SWT-7000IV		
Display method	Graphic LCD (data/message), Backlight		
Ranges	Depending on optional probes		
Calibrations (CAL)	2–point calibration Zero: metal substrate calibration Calibration standard: metal substrate and thickness standard calibration		
Additional functions	 Switching measuring modes (hold/non-interrupt) Switching display resolutions (depending on a connecting probe) Switching of units Auto Power Off (about 3 min.), releasing and reactivating Setting for exclusive substrate mode (only when SFN-325 probe is connected) Backlight Data output to PC (USB terminals) 		
Keys	① , ZERO , ▲☆ , ▼ , CAL		
Power	 3V DC Dry Battery (LR6 × 2), Continuous operation hours about 50 hours[*] AC adaptor Maximum (may vary depending on usage conditions) 		
Operating Temperature	$0 \sim 40^{\circ}$ C (Non-condensing)		
Accessories	Dry battery, Carrying case, Hand strap cord, Inspection certificate, CD (Instruction manual, USB driver, etc.)		
Option	For ferrous substrate probe (SFe), For nonferrous substrate probe (SNFe), Dual ferrous/nonferrus substrate probe (SFN-325), AC adaptor, USB cable		
Dimensions	72(W) × 32(H) × 156(D)mm		
Weight	About 200g		



Probe (option)

Model	SFN-325	SFe-0. 6Pen	SFe-0. 6L
Measuring method	Dual (Electromagnetic/Eddy current) type (auto-selection for Fe/NFe)	Electromagnetic type	
Measuring range	Fe: 0~3. 00mm, NFe: 0~2. 50mm	0~6	00 μ m
	1μm: 0~999μm 0. 01mm: 1. 00~3. 00mm (Fe) : 1. 00~2. 50mm (NFe)	1μm: 0~600μm	
Resolutions	by outtables	by switching	
	0. 1 μ m: 0~400 μ m 0. 5 μ m: 400~500 μ m	0. 1 μ m: 0~400 μ m 0. 5 μ m: 400~500 μ m	
Accuracies (to flat, smooth face)	$0 \sim 100 \mu\text{m}: \pm 1 \mu\text{m} \text{ or } \pm 2\%$ of reading 101 $\mu\text{m} \sim 3$. 00mm: $\pm 2\%$ (Fe) 101 $\mu\text{m} \sim 2$. 50mm: $\pm 2\%$ (NFe)	0~100µm: ±1µm or ±2% of reading 101~600µm: ±2%	
One point contact constant pressure typ Probes V-cut about ϕ 15 × 51mm		One point contact constant pressure typ V−cut about φ5.5 × 92.5mm	One point contact constant pressure typ about $8 \times 13.5 \times 119$ mm (Minimum measuring Diameter ϕ 16)
Options	V type probe adaptors [%]	_	
Accessaries	Thickness standards, Zero plates for testing(Fe/NFe)	Thickness standards, Zero plates for testing(Fe)	
Fe: coating, lining, thermal spray film, plating (except electrolyte nickel plating), etc. on magnetic metal substrate like iron, sterMeasuring objectsNFe: relatively general use objects like insulate films on non-magnetic metal substrate like aluminum, cupper, etc.		Coating, lining, thermal spray film, plating (except electrolyte nickel plating), etc. on magnetic metal substrate like iron, steel. Small parts, narrow places, and so on.	

% 3 kinds of V type probe adaptors (less $\phi 5, \phi 5 \sim 10, \phi 10 \sim 20$)



Probe (option)

Model	SFe-2. 5 ^{%1} /SFe-2. 5L	SFe-2. 5LwA	SFe-10	SFe-20
Measuring method	Electroma		agnetic type	
Measuring range	0~2. 50mm		0~10mm	0~20mm
Resolutions	$1 \mu\mathrm{m}:0\sim999\mu\mathrm{m}$ 0. 01mm: 1. 00~2. 50mm by switching 0. $1 \mu\mathrm{m}:0\sim400\mu\mathrm{m}$ 0. $5 \mu\mathrm{m}:400\sim500\mu\mathrm{m}$		1μm: 0~999μm 0.01mm: 1~10mm	1μm: 0~999μm 0. 01mm: 1~5mm 0. 1mm: 5~20mm
Accuracies	0~100µm: ±1µm	or $\pm 2\%$ of reading	$0\sim3$ mm: $\pm(5\mum+3\%$ of reading)	
(to flat, smooth face)	101 µ m∼2. 50mm: :	±2%	3. 01mm or over: ±3%	
Probes	One point contact constant pressure type V-cut SFe-2. 5: about ϕ 15 × 47mm SFe-2. 5L: about 18 × 22 × 67mm	One point contact constant pressure type Measuring part: about 24 × 27 × 56mm Full length (flexible): about 546~1530mm	One point contact constant pressure type V−cut about ¢21×47mm	One point contact constant pressure type V–cut about ϕ 35 × 55mm
Options	V type probe adaptors ^{%2}	-	-	_
Accessaries	Thickness standards, Zero plates for testing (Fe)	Thickness standards, Zero plates for testing (Fe), Carring case	Thickness standards, Zero plates for testing(Fe)	
Measuring objects	Coating, lining, thermal spray film, plating (except electrolyte nickel plating), etc. on magnetic metal substrate like iron, steel.	For coating thickness on remote, unreachable place of coating, lining on magnetic metal substrate like iron, steel.	On magnetic metal su For relatively thicker objects	ıbstrate like iron, steel For thick objects

X1: Heat-resistant (about 200°C) for probe Fe−2.5

: 3 kinds of V type probe adaptors (less ϕ 5, ϕ 5~10, ϕ 10~20)



◆ Probe (option)

Model	SNFe-2. 0/SNFe-2. 0L	SNFe-0. 6	SNFe-5	SNFe-8
Measuring method	Eddy current type			
Measuring range	0 ~ 2. 00mm	0∼600µm	0 ~ 5. 00mm	0 ~ 8. 00mm
Resolutions	1 μ m: 0~999 μ m 0. 01mm: 1. 00~2. 00mm by switching 0. 1 μ m: 0~400 μ m 0. 5 μ m: 400~500 μ m	$1 \mu\mathrm{m}: 0 \sim 600 \mu\mathrm{m}$ by switching 0. $1 \mu\mathrm{m}: 0 \sim 400 \mu\mathrm{m}$ 0. $5 \mu\mathrm{m}: 400 \sim 500 \mu\mathrm{m}$	1μm: 0∼999μm 0. 01mm: 1∼5mm	1µm: 0∼999µm 0. 01mm: 1∼8mm
Accuracies (to flat, smooth face)	$0 \sim 100 \mu\text{m}: \pm 1 \mu\text{m}$ or $\pm 2\%$ of reading $101 \mu\text{m} \sim 2.00 \text{mm}: \pm 2\%$	0~100μm: ±1μm or ±2% of reading 101~600μm: ±2%	$0 \sim 3 \text{mm}: \pm (5 \mu \text{ r})$ 3. 01mm or over:	n+3% of reading) ±3%
Probes	One point contact constant pressure type V-cut SNFe-2. 0: about ϕ 15 × 47mm SNFe-2. 0L: about 18 × 22 × 67mm	One point contact constant pressure type V−cut about ¢13×45.5mm	One point contact constant pressure type V–cut about ϕ 20.5 × 47mm	One point contact constant pressure type V-cut about ϕ 35 × 59mm
Options	V type probe adaptors [*] /-		_	_
Accessaries	Thickness standards, Zero plate for testing(NFe)			
Insulated films on non-magnetic substarate metal like aluminum, cupper, etc			ıpper, etc.	
Measuring objects	Relatively general use objects	For high stability with narrow bars, small tubes, minute pieces	For relativfely	thicker objects

 \times 3 kinds of V type probe adaptors (less ϕ 5, ϕ 5~10, ϕ 10~20)

Reference (measurement principles)

Electromagnetic type

When metals approach to AC- magnetic fields emitted from probe, the metal and the magnet pull each other.

It makes the pulling force stronger as they come closer. In other words, it makes the magnetic density higher as they come closer. On the contrary, it weakens the magnetic density as they move away from each other. This symptom means that magnetism emitted from probe has Higher Transferability when they come closer, and lower Transferability when they move away from each other. These levels of transferability of the magnetism co-relate with thicknesses of films coated on substrates. By analyzing correlations of transferability/less transferability (Reluctance), and thicknesses of the films on the substrates. the correlated values can be converted to the thickness, actually by measuring the Reluctance to be processed. Because it is difficult to observe and measure magnetic volumes. it is necessary that the Reluctance volumes be converted to electric volumes using coils and methods of the Principle of Electromagnetic Induction so that the measured values can be processed and converted to the thickness values.



Eddy Current Type

The eddy current is induced on the surface of metals when metals approach to alternating current fields emitted from probe. As the metal comes closer to the probe, the eddy current increases and the magnetic field density becomes high. On the contrary, as the metal move away from the probe, the eddy current decreases and the magnetic density becomes low: Correlations of between density of magnetic field and film thicknesses on the substrate are analyzed beforehand. It measure the thicknesses by converting to the thickness value from the

magnetic density measured through the above correlations. Because it is difficult to observe and measure the density of a magnetic field, it is necessary that a coil be put in magnetic fields and converted to electric volumes for measurements using the Principle of Electromagnetic Induction so that the measured value can be processed and converted to the thickness value. Generally in the eddy current type, it varies in measurement range on nonmagnetic substrate by dividing substrates by a high-wave transferable like Alumi and Copper and non-transferable like irons to optimize the measurement methods.





Coating thickness meter, Pinhole detector, Moisture meter, Concrete covermeter, Condensator, Needle detector, Iron piece detector, Viscosity cup



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